| Search Notes | | | |
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| Application/Control No. | Applicant(s)/Patent under Reexamination | |
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| 10/080,795 | KAMME ET AL. | |
| Examiner | Art Unit | |
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| | DATE | EXMR |
| Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) see enclosed for text-search strategy | 12/21/2005 | YJK |
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